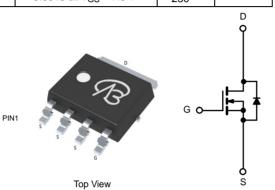


SQJ174EP-T1_GE3-VB Datasheet N-Channel 60-V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^{a, c}	Q _g (Typ.)			
60	0.0012 at V _{GS} = 10 V	270	00.70			
60	0.0015 at $V_{GS} = 7.5 \text{ V}$	250	80 nC			



FEATURES

- SGT Power MOSFET
- 100 % R_q and UIS Tested



APPLICATIONS

- Synchronous Rectification
- Power Supplies

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V _{DS}	60	V		
Gate-Source Voltage		V _{GS}	± 20	v	
	T _C = 25 °C		270 ^{a, c}		
Continuous Drain Current (T _{.I} = 175 °C)	T _C = 70 °C	, [180 ^c	A	
Continuous Diam Curient (1) = 173 C)	T _A = 25 °C	I _D	35 ^b		
	T _A = 70 °C		30 ^b	7	
Pulsed Drain Current	I _{DM}	425			
Avalanche Current Pulse	L = 0.1 mH	I _{AS}	85		
Single Pulse Avalanche Energy	L = 0.1 IIII	E _{AS}	360	mJ	
Continuous Source-Drain Diode Current	T _C = 25 °C	l-	150 ^{a, c}	Λ.	
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	2.8 ^b	Α	
	T _C = 25 °C		416 ^a	w	
Marianas Davies Discipation	T _C = 70 °C	В	291		
Maximum Power Dissipation	T _A = 25 °C	P _D	3.75 ^b		
	T _A = 70 °C		2.6 ^b		
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 175	°C		

N-Channel MOSFET

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^b	Steady State	R _{thJA}	32	40	°C/W		
Maximum Junction-to-Case	Steady State	R_{thJC}	0.30	0.36			

Notes:

- a. Based on $T_C = 25$ °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. Calculated based on maximum junction temperature. Package limitation current is 150 A.

服务热线:400-655-8788

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V, I}_{D} = 250 \mu\text{A}$	60			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA		30		>//00
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_{J}$	1 _D = 250 μΑ		- 8		mV/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1		3	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zoro Coto Voltago Brain Current	I _{DSS}	V _{DS} = 60 V, V _{GS} = 0 V			1	
Zero Gate Voltage Drain Current		V _{DS} = 60 V, V _{GS} = 0 V, T _J = 55 °C			10	μA
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	150			Α
Danie Course Co Otata Basista and	D	$V_{GS} = 10 \text{ V}, I_D = 30 \text{ A}$		0.0012		Ω
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 7.5 \text{ V}, I_D = 20 \text{ A}$		0.0015		
Forward Transconductance ^a	9 _{fs}	$V_{DS} = 15 \text{ V}, I_{D} = 30 \text{ A}$		100		S
Dynamic ^b						
Input Capacitance	C _{iss}			5500		
Output Capacitance	C _{oss}	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		1550		pF
Reverse Transfer Capacitance	C _{rss}			420		
Total Gate Charge	Q_g			80	100	
Gate-Source Charge	Q _{gs}	$V_{DS} = 20 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 20 \text{ A}$		25		nC
Gate-Drain Charge	Q_{gd}			15		
Gate Resistance	R_g	f = 1 MHz		0.85	1.3	Ω
Turn-On Delay Time	t _{d(on)}			20	30	
Rise Time	t _r	V_{DD} = 20 V, R_L = 1.0 Ω		11	17	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 20 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		77	115	1
Fall Time	t _f			10	15	
Turn-On Delay Time	t _{d(on)}			20		ns
Rise Time	t _r	V_{DD} = 20 V, R_L = 1.0 Ω		18		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 20 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		50		
Fall Time	t _f			30		
Drain-Source Body Diode Characteristic	s					
Continuous Source-Drain Diode Current	Is	T _C = 25 °C			150	۸
Pulse Diode Forward Current ^a	I _{SM}				250	Α
Body Diode Voltage	V_{SD}	I _S = 10 A		0.8	1.2	V
Body Diode Reverse Recovery Time	t _{rr}	-		50		ns
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 20 A, di/dt = 100 A/μs, T _J = 25 °C		40	65	nC
Reverse Recovery Fall Time	t _a			20		ns
Reverse Recovery Rise Time	t _b			17		

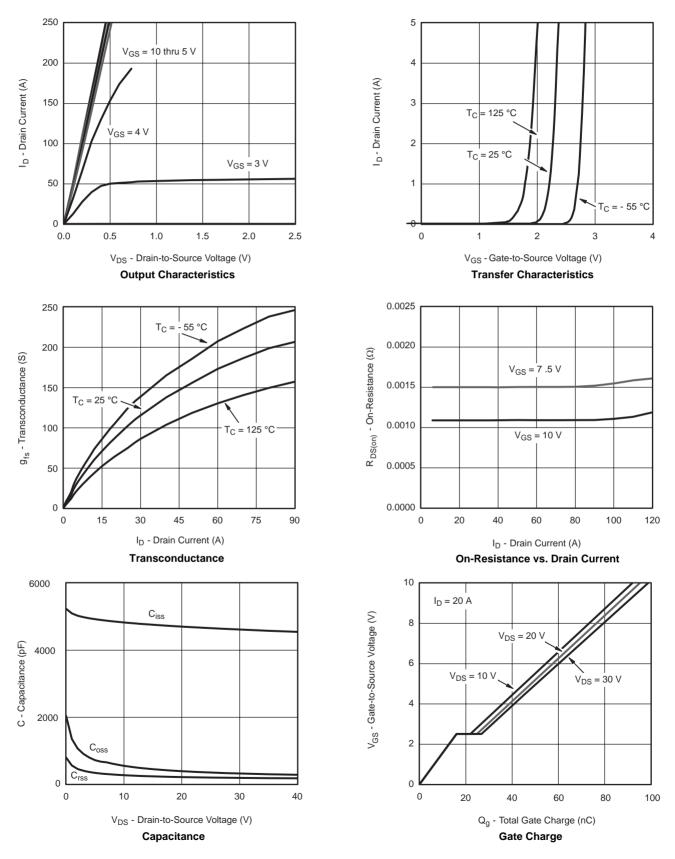
Notes:

- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

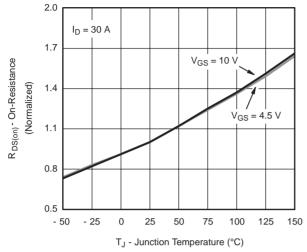


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

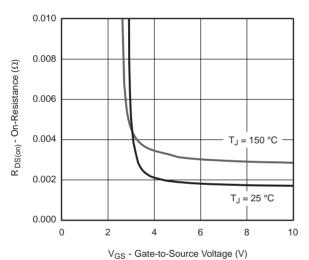




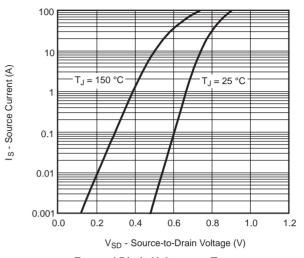
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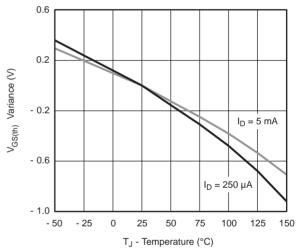
On-Resistance vs. Junction Temperature



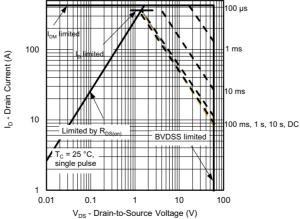
On-Resistance vs. Gate-to-Source Voltage



Forward Diode Voltage vs. Temperature



Threshold Voltage

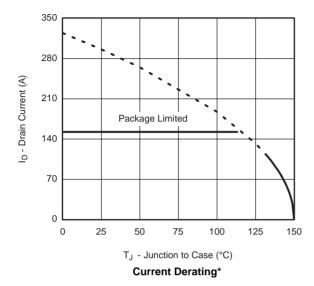


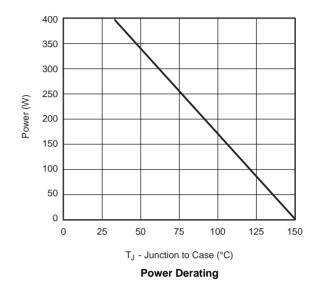
* V_{GS} > minimum V_{GS} at which R_{DS(on)} is specified

Safe Operating Area, Junction-to-Ambient

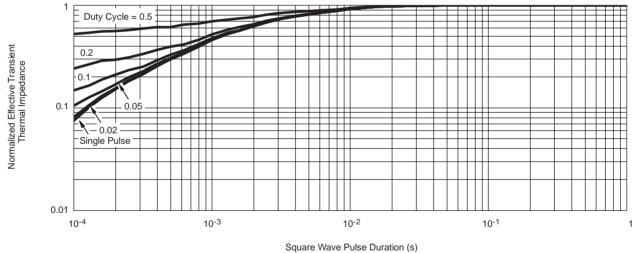


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





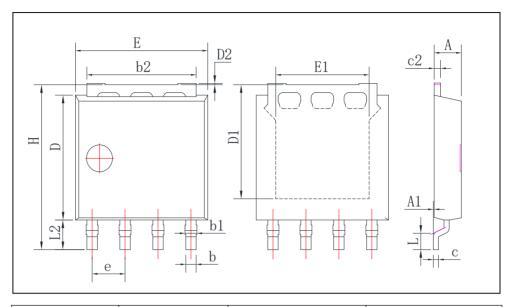
 $^{^{\}star}$ The power dissipation P_D is based on T_J = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



Normalized Thermal Transient Impedance, Junction-to-Case



LFPAK56 CASE OUTLINE



Symbol	Min	Тур	Max
A	1.00	1.05	1.10
A1	0.00		0.15
ь	0.35	0.40	0.50
b1	0.40	0.48	0.58
b2	4.01	4.21	4.41
С	0.18	0.20	0.25
c2	0.23	0.25	0.30
D	4.44	4.59	4.70
D1	4.10	4.24	4.40
D2			0.20
e	1.22	1.27	1.32
Е	5.00	5.10	5.25
E1	3.50	3.60	3.70
Н	6.05	6.15	6.25
L	0.40	0.60	0.80
L2	0.90	1.10	1.30



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